## Notice of References Cited Application/Control No. 10/612,173 Examiner BINH Q. TRAN Applicant(s)/Patent Under Reexamination LIU, YI Page 1 of 1

## **U.S. PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
	Α	US-6,679,052 B2	01-2004	Nakatani et al.	60/297
	В	US-6,655,133 B2	12-2003	Mikami et al.	60/296
	С	US-6,644,023 B2	11-2003	Hirota et al.	60/297
	D	US-6,321,530 B1	11-2001	Hoshi et al.	60/274
	Е	US-6,212,885 B1	04-2001	Hirota et al.	60/288
	F	US-			
	G	US-			
	Н	US-			
	1	US-			
	J	US-			
	К	US-			
	L	US-			
	М	US-			

## FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	Ν					
	0		3			
	Р					
	Ø	•				
	R					
	S					
	Τ					

## **NON-PATENT DOCUMENTS**

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)				
	U					
	V					
	w					
	ļ					
	x					

\*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)

Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.